



# **EMC Test Report**

**Project No.** : 1712C140

**Equipment**: Gaming Mouse Mat

Test Model : RZ02-0250

Series Model : RZ02-0250XXXX-XXXX (X: Can be 0-9, A-Z)

**Applicant**: Razer Inc.

Address : 201 3rd Street, Suite 900, San Francisco, CA 94103,

USA

Date of Receipt: Dec. 14, 2017

**Date of Test**: Dec. 14, 2017 ~ Dec. 22, 2017

Issued Date : Dec. 25, 2017
Tested by : BTL Inc.

Testing Engineer : Helen Wang) (Helen Wang)

# BTL INC.

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#### **Declaration**

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**BTL**'s reports apply only to the specific samples tested under conditions. It is manufacture's responsibility to ensure that additional production units of this model are manufactured with the identical electrical and mechanical components. **BTL** shall have no liability for any declarations, inferences or generalizations drawn by the client or others from **BTL** issued reports.

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#### Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective.

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# **REPORT ISSUED HISTORY**

Issued No.	Description	Issued Date
BTL-EMC-1-1712C140	Original Issue.	Dec. 25, 2017

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#### 1. CERTIFICATION

Equipment : Gaming Mouse Mat

Brand Name: RAZER
Test Model: RZ02-0250

Series Model: RZ02-0250XXXX-XXXX (X: Can be 0-9, A-Z)

Applicant : Razer Inc.

Manufacturer: Razer (Asia-Pacific) Pte.,Ltd.

Address : 514 Chai Chee Lane #07-01 ~ 06 Singapore 469029, Tel: +65 6505 2188 Factory : RAZER TECHNOLOGY AND DEVELOPMENT (SHENZHEN) CO., LTD

Address : East Wing, 3rd Floor, Block 2, Phase 1 of Vision Shenzhen Business Park Keji

South Road, Hi-Tech Industrial Park, Shenzhen 518057, China

Date of Test : Dec. 14, 2017 ~ Dec. 22, 2017

Test Sample : Engineering Sample Standard(s) : EN 55032: 2015 Class B

EN 55024: 2010+A1:2015 EN 61000-4-2: 2009

EN 61000-4-3: 2006+A1:2008+A2:2010

EN 61000-4-4: 2012 EN 61000-4-5: 2014

EN 61000-4-6: 2014+AC:2015

EN 61000-4-8: 2010 EN 61000-4-11: 2004

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

The test data, data evaluation, and equipment configuration contained in our test report (Ref No. BTL-EMC-1-1712C140)were obtained utilizing the test procedures, test instruments, test sites that has been accredited by the Authority of TAF according to the ISO-17025 quality assessment standard and technical standard(s).

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# 2. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

Emission					
Standard(s)	Test	Test Item		Judgment	Remark
	Radiated emissions up to 1 GHz Radiated emissions above 1 GHz		Class B	PASS	
			Class B	N/A	NOTE (1) NOTE (2)
	Radiated emissions from FM receivers			N/A	NOTE (1) NOTE (6)
EN 55032: 2015	Conducted AC mains p		Class B	PASS	NOTE (7)
	Asymmetric	AAN		N/A	
	mode conducted	Current Probe		N/A	NOTE (1) NOTE (8)
emissions	emissions	CVP		N/A	
	Conducted voltage e			N/A	NOTE (1) NOTE (9)

Immunity EN 55024: 2010+A1:2015				
Section(s)	Test Item	Performance Criterion	Judgment	Remark
EN 61000-4-2:2009	Electrostatic discharge immunity	В	PASS	
EN 61000-4-3: 2006+A1:2008+A2:2010	Radiated, radio-frequency, electromagnetic field immunity			
EN 61000-4-4:2012	Electrical fast transient/burst immunity	В	PASS	
EN 61000-4-5:2014	Surge immunity B/C		PASS	NOTE (4)
EN 61000-4-6: 2014+AC :2015	Immunity to conducted disturbances, induced by radio-frequency fields	А	PASS	
EN 61000-4-8:2010	Power frequency magnetic field immunity	Α	PASS	
EN 61000-4-11:2004	Voltage dips, short interruptions and voltage variations immunity	B/C/C	PASS	NOTE (5)

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#### NOTE:

- (1) "N/A" denotes test is not applicable to this device.
- (2) The EUT's max operating frequency is 12 MHz which does not exceed 108 MHz, so the test will not be performed.
- (3) If the power consumption is less than 75W, there is no limit applied.
- (4) Performance Criterion C for signal ports and telecommunication ports. Performance Criterion B for input d.c. power port and a.c. power ports.
- (5) Voltage Dips: >95% reduction Performance Criterion B Voltage Dips: 30% reduction - Performance Criterion C Voltage Interruptions: >95% reduction - Performance Criterion C
- (6) If the EUT has FM function the test will be performed.
- (7) If the EUT has AC power mains port the test will be performed.

(8)

Cable Type	Number of pairs	Measurement type	Procedures
Balanced Unscreened	1 (2 wire) ;2 (4 wire); 3 (6 wire) ;4 (8 wire)	Voltage	AAN
Balanced Unscreened	See a)	Voltage and Current	CP+CVP
Screened or Coaxial	n/a	Voltage	AAN
Screened or Coaxial	n/a	Voltage or Current	CP or CVP
Unbalanced cables	n/a	Voltage and Current	CP+CVP

Ports connected to cables with more than 4 balanced pairs or where the port is unable to function correctly when connected through an AAN.

- (9) If the EUT has tuner port the test will be performed.
- (10) The requirement followed by the client's specification.

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#### 2.1 TEST FACILITY

The test facilities used to collect the test data in this report is at the location of No.3, Jinshagang 1st Road, Shixia, Dalang Town, Dongguan, Guangdong, China.

#### 2.2 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2, The BTL measurement uncertainty is less than the CISPR 16-4-2 U<sub>cisor</sub> requirement.

The reported uncertainty of measurement  $\mathbf{y} \pm \mathbf{U}$ , where expanded uncertainty  $\mathbf{U}$  is based on a standard uncertainty multiplied by a coverage factor of  $\mathbf{k=2}$ , providing a level of confidence of approximately 95%.

A. Radiated emissions up to 1 GHz measurement:

Test Site	Method	Measurement Frequency Range	Ant. H / V	U, (dB)
		30MHz ~ 200MHz	V	4.66
DG-CB08	CISPR	30MHz ~ 200MHz	Н	4.64
(10m)	CISER	200MHz ~ 1,000MHz	V	4.88
		200MHz ~ 1,000MHz	Η	4.86

B. Conducted emissions AC mains power port measurement:

Test Site	Method	Measurement Frequency Range	U, (dB)
DG-C02	CISPR	150 kHz ~ 30MHz	2.32

C. Immunity Measurement:

Test Site	Method	Measurement Frequency Range	U, (dB)
		Rise time tr	14.6 %
DG-SR02	EN 61000-4-2	Peak current Ip	7.70 %
DG-3K02	EN 01000-4-2	Current at 30 ns	7.72 %
		Current at 60 ns	7.72 %
		80MHz~1GHz	2.175 dB
DG-CB05	EN 61000-4-3	Electrical measurements	2.267 dB
DG-CB03	LIN 01000-4-3	Measuring the demodulation on analogue wired network lines	2.267 dB
		Voltage rise time (tr)	10.4 %
DG-SR05	EN 61000-4-4	Voltage peak value(V <sub>P</sub> )	8.2 %
		Voltage pulse width(tw)	6.0 %
		Voltage front time (T <sub>fv</sub> )	5.8 %
DG-SR05	EN 61000-4-5	Voltage peak value(V <sub>P</sub> )	3.9 %
		Voltage duration(t <sub>d</sub> )	0.6 %
		CDN	3.25 dB
		EM Clamp	4.410 dB
DG-CB06	EN 61000-4-6	Electrical measurements	3.258 dB
		measuring the demodulation on analogue wired network lines	3.258 dB
DG-SR05	EN 61000-4-8	Magnetic Field Level	3.787 %
DG-SR05	EN 61000-4-11	voltage fall time (T <sub>f</sub> )	2 %

Note: Unless specifically mentioned, the uncertainty of measurement has not been taken into account to declare the compliance or non-compliance to the specification.

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# 3. GENERAL INFORMATION

#### 3.1 GENERAL DESCRIPTION OF EUT

Equipment	Gaming Mouse Mat	
Brand Name	RAZER	
Test Model	RZ02-0250	
Series Model	Series Model RZ02-0250XXXX-XXXX (X: Can be 0-9, A-Z)	
Model Difference	It is the same as the basic model and X is used to define which country	
Model Difference	it is for under the same family series.	
Power Source	Supplied from USB port.	
Power Rating	DC5V 180mA	

#### Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the user's manual.

# 3.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Operating

For Radiated Test				
Final Test Mode Description				
Mode 1 Operating				

For Conducted Test				
Final Test Mode Description				
Mode 1	Operating			

For EMS Test				
Final Test Mode Description				
Mode 1	Operating			

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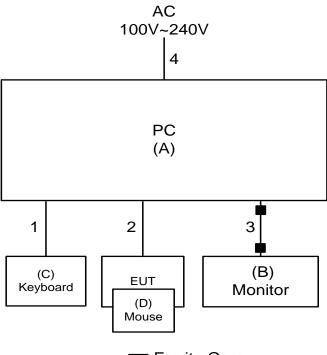


#### 3.3 EUT OPERATING CONDITIONS

The EUT exercise program used during radiated and/or conducted emission measurement was designed to exercise the various system components in a manner similar to a typical use. The standard test signals and output signal as following:

- 1. EUT connected to PC via USB cable.
- 2. PC connected to keyboard via USB cable.
- 3. PC connected to monitor via D-SUB cable.
- 4. The mouse is putted on the EUT.

# 3.4 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED



Ferrite Core

#### 3.5 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	FCC ID	Series No.
Α	PC	DELL	9010 MT	DOC	HOTQ2W1
В	Monitor	DELL	E117FPC	N/A	CN-OFJ179-64180-6AG-IWNS
С	Keyboard	DELL	L100	DOC	CNORH6596589071T08NE
D	Mouse	DELL	MS111-P	DOC	CN011D3V71581279OLOT

Item	Shielded Type	Ferrite Core	Length	Note
1	YES	NO	1.8m	USB Cable
2	YES	NO	1.8m	USB Cable
3	YES	YES	1.8m	D-SUB Cable
4	YES	NO	1.8m	AC Cable

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# 4. EMC EMISSION TEST

#### 4.1 RADIATED EMISSION

#### **4.1.1 LIMITS**

Class A equipment up to 1000MHz

Table clause	Frequency range MHz	Facility (see Table A.1)	Class A limits dB(μV/m)		
A2.1	30-230 230-1000	OATS/SAC	10	Quasi poak /	40 47
	30-230	OATS/SAC	3	Quasi peak / 120 kHz	50
A2.2	230-1000	UATS/SAC	3		57
	30-230	EAD	10		42 to 35
A2.3	230-1000	FAR	10	Quasi peak /	42
	30-230	FAR	3	120 kHz	52 to 45
A2.4	230-1000	IAK	3		52

Apply only A2.1 or A2.2 or A2.3 or A2.4 across the entire frequency range.

Class B equipment up to 1000MHz

Table	Frequency		Class B limits		
clause	range MHz	Facility (see Table A.1)	Distance m	Detector type/ bandwidth	dB(μV/m)
	30-230	OATS/SAC	10		30
A4.1	230-1000	OA13/3AC	10	Quasi peak /	37
	30-230	OATS/SAC	3	120 kHz	40
A4.2	230-1000	OA13/3AC	5		47
	30-230	FAR	10		32 to 25
A4.3	230-1000	FAR	10	Quasi peak /	32
	30-230	FAR	3	120 kHz	42 to 35
A4.4	230-1000	FAR	3		42

Apply only table clause A4.1 or A4.2 or A4.3 or A4.4 across the entire frequency range. These requirements are not applicable to the local oscillator and harmonics frequencies of equipment covered by Table A.6.

#### Notes:

- (1) The limit for radiated test was performed according to as following: EN 55032
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m)=20log Emission level (uV/m).
- (4) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Antenna Factor + Cable Loss - Amplifier Gain(if use) Margin Level = Measurement Value - Limit Value





Required highest frequency for radiated measurement

Highest internal frequency (F <sub>x</sub> )	Highest measured frequency		
MHz	MHz		
F <sub>x</sub> ≦108	1000		
108 <f<sub>x ≤500</f<sub>	2000		
500 < F <sub>x</sub> ≤ 1000	5000		
F <sub>x</sub> >1000	5 <sup>th</sup> up to a maximum 6 GHz,		

Note for FM and TV broadcast receiver,  $F_x$  is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

# **4.1.2 MEASUREMENT INSTRUMENTS LIST**

# Up to 1GHz:

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Pre-Amplifier	Mini-Circuits	EMC 9135	980284	Mar. 26, 2018
2	Pre-Amplifier	Mini-Circuits	EMC 9135	980283	Mar. 26, 2018
3	Trilog-Broadband Antenna	Schwarzbeck	VULB9168	586	Mar. 26, 2018
4	Trilog-Broadband Antenna	Schwarzbeck	VULB9168	587	Mar. 26, 2018
5	Cable	emci	LMR-400(5 m+11m+15 m)	N/A	Nov. 03, 2018
6	Cable	emci	LMR-400(5 m+8m+15 m)	N/A	Nov. 03, 2018
7	Measurement Software	Farad	EZ-EMC Ver.BTL-2A NT-1	N/A	N/A
8	Multi-Device Controller	ETS-Lindgren	2090	N/A	N/A
9	Attenuator	N/A	SA18N-06	6dB	Apr. 14, 2018
10	Attenuator	N/A	SA18N-06	6dB	Apr. 14, 2018
11	Receiver	Keysight	N9038A	MY54450004	Aug. 15, 2018
12	MXE EMI Receiver	Agilent	N9038A	MY53220133	Jun. 20, 2018

Remark: "N/A" denotes no model name, no serial no. or no calibration specified.

All calibration period of equipment list is one year.

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#### 4.1.3 TEST PROCEDURE

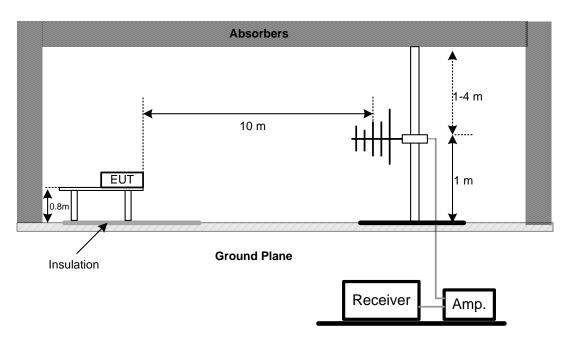
- a. The measuring distance of 10 m shall be used for measurements. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.(below 1GHz).
- b. The height of the equipment or of the substitution antenna shall be 0.8 m, the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- c. The initial step in collecting radiated emission data is a receiver peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- d. All readings are Peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform. (below 1GHz)
- e. For the actual test configuration, please refer to the related Item Block Diagram of system tested (please refer to 3.3).

#### 4.1.4 DEVIATION FROM TEST STANDARD

No deviation

#### 4.1.5 TEST SETUP

**UP TO 1 GHZ** 



Note: The antenna can be moved between 1 to 4 meters above the ground.

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# 4.1.6 MEASUREMENT DISTANCE

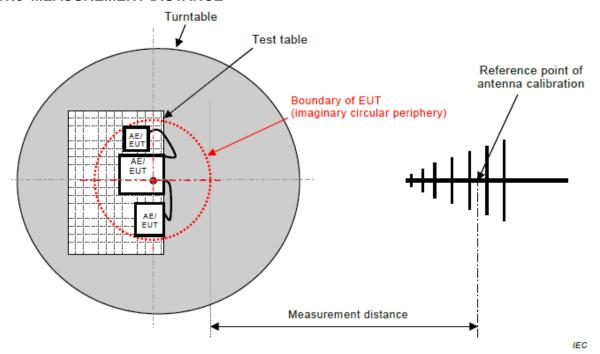


Figure C.1 - Measurement distance

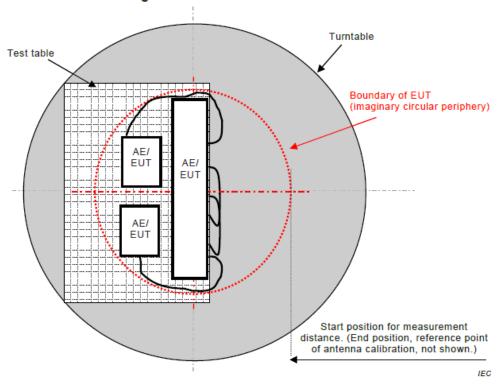


Figure C.2 – Boundary of EUT, Local AE and associated cabling

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# 4.1.7 TEST RESULTS (UP TO 1 GHZ)

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	60%
Test Voltage	DC 5V	Polarization	Vertical
Test Mode	Operating		
Test Engineer	Helen Wang		



No.	Freq.	Keading Level	Correct Factor	Measure ment	Limit	Margin	
	MHz	dBuV/m	dB	dBuV/m	dBuV/m	dB	Detector
1 *	36. 3050	50. 20	-23.69	26. 51	30.00	-3.49	QP
2	141. 5500	44.48	-22. 07	22.41	30.00	<b>−7. 59</b>	QP
3	599.8750	43.82	<b>-14.05</b>	29.77	37.00	-7. 23	QP
4	756. 0450	38. 66	-11. 17	27.49	37.00	-9. 51	QP
5	870.0200	39. 22	-9. 95	29. 27	37.00	-7. 73	QP
6	943. 2550	38. 96	-8. 12	30. 84	37.00	-6. 16	QP

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EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	60%
Test Voltage	DC 5V	Polarization	Horizontal
Test Mode	Operating		
Test Engineer	Helen Wang		



No.	Freq.	Reading Level	Correct Factor	Measure ment	Limit	Margin	
	MHz	dBuV/m	dB	dBuV/m	dBuV/m	dB	Detector
1	52.3100	33. 01	<b>−16. 0</b> 8	16. 93	30.00	-13.07	QP
2	139.6100	33. 76	-15. 69	18. 07	30.00	-11. 93	QP
3	172. 5900	31. 27	-15. 24	16. 03	30.00	-13. 97	QP
4	450.0100	31.77	-9. 53	22. 24	37.00	-14.76	QP
5	578. 0500	31. 56	-6.88	24.68	37.00	-12. 32	QP
6 *	690. 5700	31. 99	-4. 78	27. 21	37.00	-9. 79	QP

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# 4.2 CONDUCTED EMISSION MEASUREMENT AT AC MAINS POWER PORTS

#### **4.2.1 LIMITS**

Requirements for conducted emissions from AC mains power ports of Class A equipment

Table clause	Frequency Range MHz	Coupling Device	Detector Type / bandwidth	Class A Limits (dB(μV))		
۸0.1	0.15 - 0.5	AMN	Quasi Peak /	79		
A9.1	0.5 - 30	AIVIIN	9 kHz	73		
A9.2	0.15 - 0.5	AMN	Average /	66		
A9.2	0.5 - 30	AIVIIN	9 kHz	60		
Apply A9.1 an	Apply A9.1 and A9.2 across the entire frequency range.					

Requirements for conducted emissions from AC mains power ports of Class B equipment

Table clause	Frequency Range MHz	Coupling Device	Detector Type / bandwidth	Class B Limits (dB(µV))
	0.15 - 0.5		Overi Deek /	66-56
A10.1	0.5 - 5	AMN	Quasi Peak / 9 kHz	56
	5 - 30			60
	0.15 - 0.5		A /	56-46
A10.2	0.5 - 5	AMN	Average / 9 kHz	46
	5 - 30		J KI IZ	50
Δηηίν Δ10 1 α	nd A10.2 across the	entire frequi	ency range	

# Apply A10.1 and A10.2 across the entire frequency range.

# NOTE:

(1) The test result calculated as following:

Measurement Value = Reading Level + Correct Factor

Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor(if use)

Margin Level = Measurement Value - Limit Value

# **4.2.2 MEASUREMENT INSTRUMENTS LIST**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Measurement Software	Farad	EZ-EMC Ver.NB-03A 1-01	N/A	N/A
2	LISN	EMCO	3816/2	00052765	Mar. 26, 2018
3	50Ω Terminator	SHX	TF2-3G-A	08122901	Mar. 26, 2018
4	TWO-LINE V-NETWORK	R&S	ENV216	101447	Mar. 26, 2018
5	EMI Test Receiver	R&S	ESCI	100382	Mar. 26, 2018
6	Cable	N/A	RG223	12m	Oct. 19, 2018

Remark: "N/A" denotes no model name, no serial no. or no calibration specified.

All calibration period of equipment list is one year.

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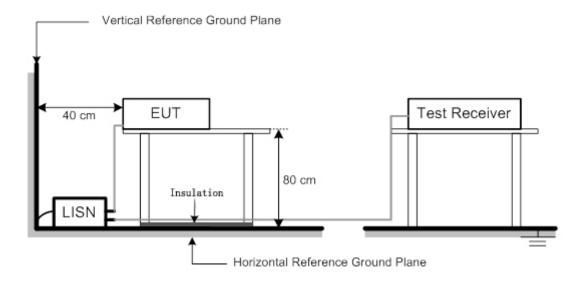
#### **4.2.3 TEST PROCEDURE**

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

#### 4.2.4 DEVIATION FROM TEST STANDARD

No deviation

#### 4.2.5 TEST SETUP



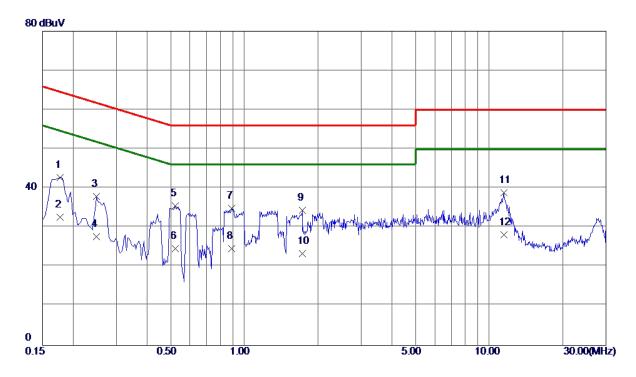
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# **4.2.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	53%
Test Voltage	DC 5V	Phase	Line
Test Mode	Operating		
Test Engineer	Helen Wang		



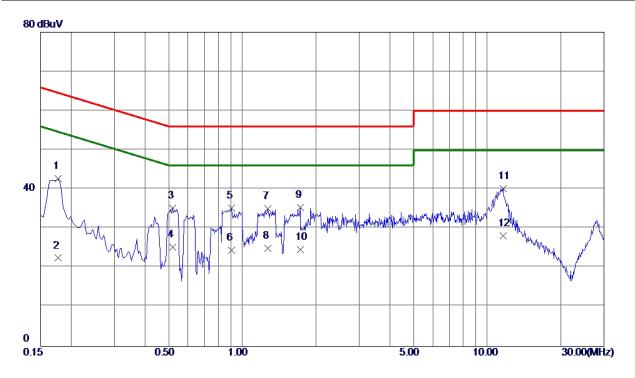
Freq.	Keading Level	Correct Factor	Measure ment	Limit	Margin	
MHz	dBuV	dB	dBuV	dBuV	dB	Detector
0.1770	32. 91	9. 78	42.69	64.63	-21. 94	QP
0.1770	22.80	9. 78	32. 58	54.63	<b>-22. 05</b>	AVG
0.2490	28. 14	9. 76	37. 90	61.79	-23.89	QP
0.2490	17. 90	9. 76	27.66	51.79	-24. 13	AVG
0. 5235	25. 68	9.80	35. 48	<b>56. 00</b>	-20. 52	QP
0. 5235	14. 90	9.80	24.70	46.00	-21. 30	AVG
0.8880	<b>25. 0</b> 2	9.85	34.87	56.00	-21. 13	QP
0.8880	14.80	9.85	24.65	46.00	-21. 35	AVG
1.7250	24. 55	9. 91	34.46	<b>56. 00</b>	-21. 54	QP
1.7250	13. 50	9. 91	23.41	46.00	<b>-22. 59</b>	AVG
11. 4584	28. 42	10.40	38. 82	60.00	-21. 18	QP
11. 4584	17. 80	10.40	28. 20	50.00	-21. 80	AVG
	MHz 0. 1770 0. 1770 0. 2490 0. 2490 0. 5235 0. 5235 0. 8880 0. 8880 1. 7250 11. 4584	MHz dBuV 0. 1770 32. 91 0. 1770 22. 80 0. 2490 28. 14 0. 2490 17. 90 0. 5235 25. 68 0. 5235 14. 90 0. 8880 25. 02 0. 8880 14. 80 1. 7250 24. 55	MHz         Level dBuV dB           0.1770         32.91         9.78           0.1770         22.80         9.78           0.2490         28.14         9.76           0.5235         25.68         9.80           0.5235         14.90         9.80           0.8880         25.02         9.85           0.8880         14.80         9.85           1.7250         24.55         9.91           11.4584         28.42         10.40	MHz         Level         Factor         ment           MHz         dBuV         dB         dBuV           0. 1770         32. 91         9. 78         42. 69           0. 1770         22. 80         9. 78         32. 58           0. 2490         28. 14         9. 76         37. 90           0. 2490         17. 90         9. 76         27. 66           0. 5235         25. 68         9. 80         35. 48           0. 5235         14. 90         9. 80         24. 70           0. 8880         25. 02         9. 85         34. 87           0. 8880         14. 80         9. 85         24. 65           1. 7250         24. 55         9. 91         34. 46           1. 7250         13. 50         9. 91         23. 41           11. 4584         28. 42         10. 40         38. 82	MHz         dBuV         dB         dBuV         dBuV           0. 1770         32. 91         9. 78         42. 69         64. 63           0. 1770         22. 80         9. 78         32. 58         54. 63           0. 2490         28. 14         9. 76         37. 90         61. 79           0. 2490         17. 90         9. 76         27. 66         51. 79           0. 5235         25. 68         9. 80         35. 48         56. 00           0. 5235         14. 90         9. 80         24. 70         46. 00           0. 8880         25. 02         9. 85         34. 87         56. 00           0. 8880         14. 80         9. 85         24. 65         46. 00           1. 7250         24. 55         9. 91         34. 46         56. 00           1. 4584         28. 42         10. 40         38. 82         60. 00	MHz         dBuV         dB         dBuV         dBuV         dB           0. 1770         32. 91         9. 78         42. 69         64. 63         -21. 94           0. 1770         22. 80         9. 78         32. 58         54. 63         -22. 05           0. 2490         28. 14         9. 76         37. 90         61. 79         -23. 89           0. 2490         17. 90         9. 76         27. 66         51. 79         -24. 13           0. 5235         25. 68         9. 80         35. 48         56. 00         -20. 52           0. 5235         14. 90         9. 80         24. 70         46. 00         -21. 30           0. 8880         25. 02         9. 85         34. 87         56. 00         -21. 13           0. 8880         14. 80         9. 85         24. 65         46. 00         -21. 35           1. 7250         24. 55         9. 91         34. 46         56. 00         -21. 54           1. 7250         13. 50         9. 91         23. 41         46. 00         -22. 59           11. 4584         28. 42         10. 40         38. 82         60. 00         -21. 18

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EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	53%
Test Voltage	DC 5V	Phase	Neutral
Test Mode	Operating		
Test Engineer	Helen Wang		



No.	Freq.	Reading Level	Correct Factor	Measure ment	Limit	Margin	
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector
1	0.1770	32. 98	9. 68	42.66	64.63	-21. 97	QP
2	0. 1770	12.80	9. 68	22.48	54.63	-32. 15	AVG
3	0.5190	25.45	9. 70	35. 15	56.00	− <b>20.</b> 85	QP
4	0.5190	15.60	9. 70	25. 30	46.00	-20.70	AVG
5	0.9060	25. 39	9. 74	35. 13	56.00	-20. 87	QP
6	0.9060	14.80	9. 74	24. 54	46.00	-21.46	AVG
7	1. 2705	25. 30	9. 76	35. 06	56.00	-20.94	QP
8	1. 2705	15. 20	9. 76	24. 96	46.00	<b>-21.04</b>	AVG
9	1.7250	25.60	9.81	35. 41	56.00	<b>-20. 59</b>	QP
10	1.7250	14.90	9.81	24.71	46.00	-21. 29	AVG
11 *	11. 5935	29. 79	10. 38	40. 17	60.00	-19.83	QP
12	11. 5935	17.81	10. 38	28. 19	50.00	-21.81	AVG

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# **5. EMC IMMUNITY TEST**

# 5.1 STANDARD COMPLIANCE/SEVERITY LEVEL/CRITERIA

Tests Standard No.	Test Specification Level / Test Mode	Test Ports	Criteria
Electrostatic discharge	±8 kV air discharge ±4 kV contact discharge (Direct Mode)	Enclosure	В
EN 61000-4-2 (ESD)	±4kV HCP discharge ±4kV VCP discharge (Indirect Mode)	Enclosure	В
Radiated, radio-frequency, electromagnetic field immunity EN 61000-4-3 (RS)	80 MHz to 1000 MHz 3V/m(unmodulated, r.m.s), 1 kHz, 80%, AM modulated	Enclosure	A
Electrical fast transient/burst	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency (100kHz Repetition Frequency for xDSL equipment)	Signal ports and telecommunication ports (Only applicable to cable length>3 m)	В
immunity EN 61000-4-4 (EFT/Burst)	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	DC Power Ports	В
	±1 kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	AC Power Ports	В
	±1 kV(peak) 10/700 Tr/Th µs( <b>NOTE</b> ) (without primary protection)	Signal ports and telecommunication ports	С
	±4 kV(peak) 10/700 Tr/Th µs( <b>NOTE</b> ) (with primary protectors fitted)	(applicable only to ports connect directly to outdoor cables)	С
Surge immunity EN 61000-4-5 (Surges)	±0.5 kV(peak) 1.2/50(8/20) Tr/Th μs	DC Power Ports (applicable only to ports connect directly to outdoor cables)	В
	±1 kV(peak) 1.2/50(8/20) Tr/Th μs (line to line)	AC Douge Deste	В
	±2 kV(peak) 1.2/50(8/20) Tr/Th µs (line to earth or ground)	AC Power Ports	В

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Immunity to conducted disturbances, induced by radio-frequency fields EN 61000-4-6 (Injected Current)	0.15 MHz to 80 MHz 3V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	Signal ports and telecommunication ports (Only applicable to cable length>3 m)	А
	0.15 MHz to 80 MHz 3V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	DC Power Ports	A
	0.15 MHz to 80 MHz 3V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	AC Power Ports	Α
Power frequency magnetic field immunity EN 61000-4-8 (PFMF)	50 Hz or 60Hz, 1A/m(r.m.s) μs	Enclosure	А
Voltage dips, short interruptions and voltage variations immunity EN 61000-4-11 (Voltage Interruption/Dips)	Voltage reduction>95% 0.5 period Voltage reduction 30% 25 periods Voltage reduction>95% 250 periods	AC Power Ports	B C C

# Note.

Where the coupling network for the 10/700 µs waveform affects the functioning of high speed data ports, the test shall be carried out using a 1,2/50 (8/20) µs waveform and appropriate coupling network.

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# **5.2 GENERAL PERFORMANCE CRITERIA**

According to **EN55024** standard, the general performance criteria as following:

Criterion A	The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.  If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B	After the test, the equipment shall continue to operate as intended without operator Intervention. No degradation of performance or loss of function is allowed, after the application of the phenomenon below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.  During the test, degradation of performance is allowed. However, no change of operating state if stored data allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the

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# 5.3 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

#### **5.3.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-2
Discharge Impedance	330 ohm / 150 pF
Required Performance	В
Discharge Voltage	Air Discharge: ±2 kV, ±4 kV, ±8 kV (Direct)
	Contact Discharge: ±2 kV, ±4 kV (Direct/Indirect)
Polarity	Positive & Negative
Number of Discharge	Air Discharge: min. 20 times at each test point
	Contact Discharge: min. 200 times in total
Discharge Mode	Single Discharge
Discharge Period	1 second minimum

#### **5.3.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	ESD Generator	TESEQ AG	NSG 437	450	Nov. 01, 2018

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.3.3 TEST PROCEDURE**

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. Contact discharge was applied to conductive surfaces (Direct) and coupling planes (Indirect) of the EUT.

During the test, it was performed with single discharges. For the single discharge time between successive single discharges was at least 1 second. The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges.

If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

Vertical Coupling Plane (VCP):

The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at a distance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the coupling plane. The four faces of the EUT will be performed with electrostatic discharge.

b. Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.

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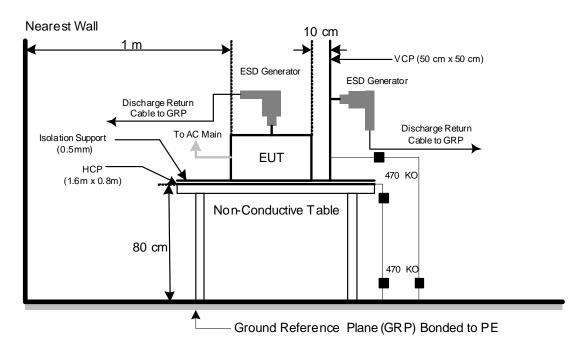




#### **5.3.4 DEVIATION FROM TEST STANDARD**

No deviation

#### 5.3.5 TEST SETUP



#### Note:

#### **TABLE-TOP EQUIPMENT**

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test was installed in a representative system as described in EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in EN 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

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#### **5.3.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz	Pressure	1010hPa
Test Mode	Operating		

Mode		Air Discharge						Contact Discharge						
	2k	۲V	41	۲V	8	kV	-	kV	2k	۲V	41	۲V	- k	۲V
Location	Р	Ν	Р	Ν	Р	N	Р	N	Р	N	Р	Ν	Р	N
1	Α	Α	Α	Α	Α	Α	-	•	Α	Α	Α	Α	-	-
2	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
Criteria			I	3				- B				-		
Result	А			-		Α				-				
Judgment			PA	SS				-		PA	ASS			-

Mode		HCP Contact Discharge					VCP Contact Discharge				arge	
	2ŀ	۲V	4	4kV		- kV		2kV		۲V	- kV	
Location	Р	N	Р	N	Р	Ν	Р	N	Р	Ν	Р	N
1	Α	Α	Α	Α	-	1	Α	Α	Α	Α	-	-
2	Α	Α	Α	Α	-	1	Α	Α	Α	Α	-	-
3	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
4	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-
Criteria		В		-			В			-		
Result	А		-			Α				-		
Judgment		PA	SS			-		PA	SS			-

# Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) Test condition:

Direct/Indirect(HCP/VCP) discharges: Minimum 50 times (Positive/Negative) at eachpoint.

Air discharges: Minimum 20 times (Positive/Negative) at each point.

- 3) Test location(s) in which discharge (Air and contact discharge) to be applied illustrated by photos shown in next page(s)
- 4) The Indirect (HCP/VCP) discharges description of test point as following: 1.left side; 2.right side; 3.front side; 4.rear side.
- 5) N/A denotes test is not applicable in this test report
- 6) Criterion A: No observation of any performance degradation.
- 7) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 8) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

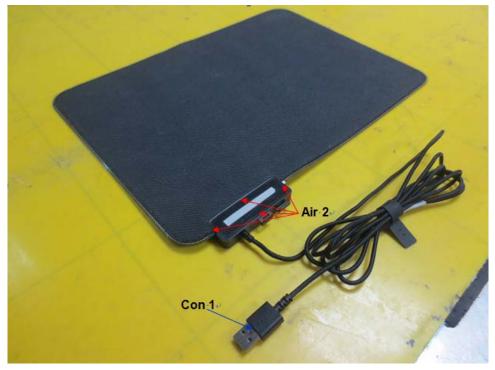
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# PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED





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#### 5.4 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

#### 5.4.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-3
Required Performance	A
Frequency Range	80 MHz - 1000 MHz
Field Strength	3 V/m(unmodulated, r.m.s)
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance	3 m
Antenna Height	1.5 m
Dwell Time	at least 3 seconds

#### **5.4.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Power amplifier	MILMEGA	80RF1000- 250	1064833	Aug. 20, 2020
2	Antenna	ETS	3142C	00047662	Mar. 26, 2018
3	Measurement Software	TOYO	IM5/RS Ver 3.8.050	N/A	N/A
4	MXG Analog Signal Generator	Agilent	N5181A	MY49060710	Aug. 20, 2018

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.4.3 TEST PROCEDURE**

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

The other condition as following manner:

- a. The field strength level was 3 V/m(unmodulated, r.m.s).
- b. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80%amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.

#### **5.4.4 DEVIATION FROM TEST STANDARD**

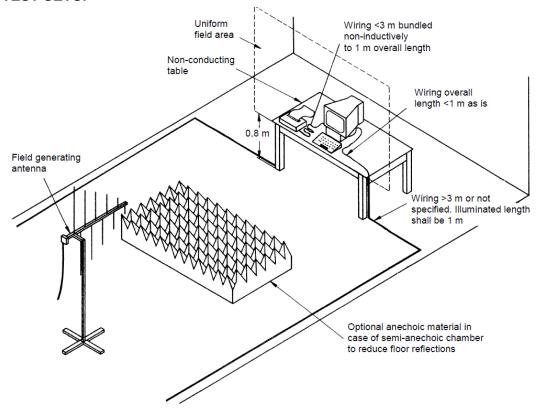
No deviation

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# 5.4.5 TEST SETUP



Note:

#### **TABLE-TOP EQUIPMENT**

The EUT installed in a representative system as described in EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

#### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

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# **5.4.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Criterion	Result	Judgment
80 - 1000	H/V	3V (unmodulated, r.m.s) AM Modulated 1000Hz, 80%	0 90 180 270	A	А	PASS

# Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) N/A denotes test is not applicable in this test report.
- 3) Criterion A: No observation of any performance degradation.
- 4) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 5) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

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# 5.5 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT/BURST)

#### **5.5.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-4
Required Performance	В
Test Voltage	Power Line: ±1 kV
Polarity	Positive & Negative
Impulse Frequency	5 kHz: except for xDSL equipment
	100 kHz: only for single lines of xDSL equipment.
Impulse Wave shape	5/50 ns
Burst Duration	15 ms
Burst Period	300 ms
Test Duration	Not less than 1 min.

#### **5.5.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 20, 2018
2	Measurement Software	Teseq	Win 3000 Version 1.2.0	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

# **5.5.3 TEST PROCEDURE**

The EUT and support equipment(s) are placed on a table that is 0.8 meter high above a metal ground plane and should be located 0.1 m+/- 0.01m high above the Ground Reference Plane (1m\*1m min. and 0.65mm thick min).

The other condition as following manner:

- a. The length of power cord between the coupling device and the EUT should not exceed 1 meter.
- b. Both positive and negative polarity discharges were applied.
- c. The duration time of each test sequential was 1 minute

#### 5.5.4 DEVIATION FROM TEST STANDARD

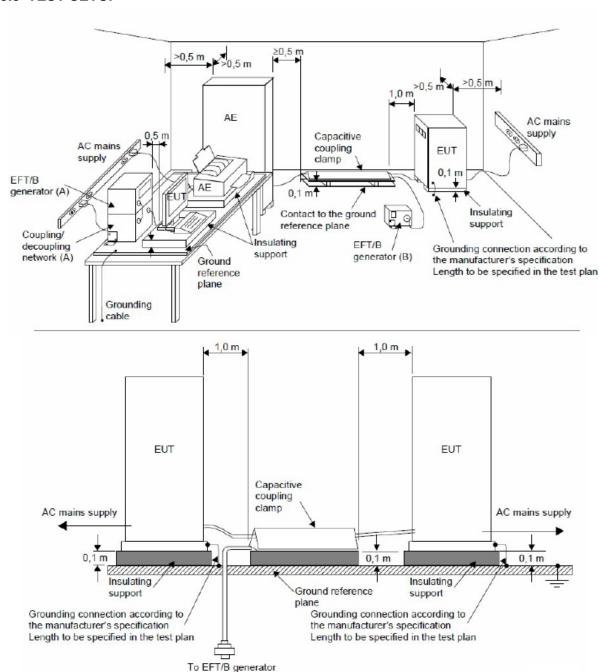
No deviation

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#### 5.5.5 TEST SETUP



#### Note:

#### **TABLE-TOP EQUIPMENT**

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane and should be located 0.1 m+/- 0.01m above the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

# FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in EN 61000-4-4 and its cables were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

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# 5.5.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

EUT Ports Tested		Polarity	Repetition Frequency	Test Level 1kV	Criterion	Result	Judgment
	Lino (L)	+	5 kHz	Α	В	А	PASS
	Line (L)	-	5 kHz	Α	Ь	Α	
AC Dower Dort	Neutral (N)	+	5 kHz	Α	В	А	PASS
AC Power Port		-	5 kHz	Α	Б		
	Cround (DE)	+	5 kHz	Α	В	_	PASS
	Ground (PE)	-	5 kHz	Α	Б	Α	rass

#### Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) N/A denotes test is not applicable in this test report
- 3) Criterion A: No observation of any performance degradation.
- 4) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 5) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

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# **5.6 SURGE IMMUNITY TEST**

# **5.6.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-5		
Required Performance	В		
Wave-Shape	Combination Wave for power lines		
	1.2/50 us Open Circuit Voltage		
	8 /20 us Short Circuit Current		
Test Voltage	Power Line: ±0.5 kV, ±1 kV, ±2 kV		
Surge Input/Output	L-N, L-PE, N-PE		
Generator Source	2 ohm between networks		
Impedance	12 ohm between network and ground		
Polarity	Positive/Negative		
Phase Angle:	AC Port: 0°/90°/180°/270°		
Pulse Repetition Rate	1 time / min. (maximum)		
Number of Tests	5 positive and 5 negative at selected points		

# **5.6.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 20, 2018
2	Measurement Software	Teseq	Win 3000 Version 1.2.0	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

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#### **5.6.3 TEST PROCEDURE**

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

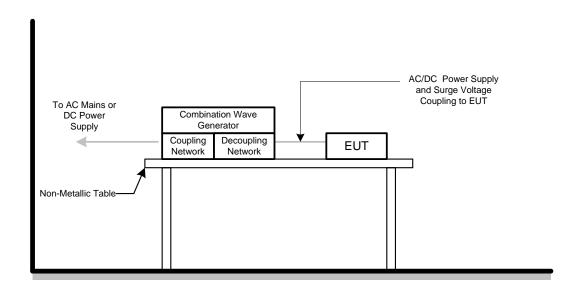
  The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

#### **5.6.4 DEVIATION FROM TEST STANDARD**

No deviation

#### 5.6.5 TEST SETUP



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# 5.6.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

Wave Form			1.2/50(8/20)Tr/Thµs							
		Polarity	Dhasa		Voltage			Criterion	Result	Judgment
LOTE	TOTIS TESTEU	Fularity	riiase	0.5kV	1kV	kV	kV			
		+/-	0°	Α	Α	-	-		А	PASS
۸.	L – N	+/-	90°	Α	Α	-	-	В		
AC	AC (2 ohm)	+/-	180°	Α	Α	-	-	В		
		+/-	270°	Α	Α	-	-			

10/0	vo Form	1.2/50(8/20)Tr/Thµs								
	Wave Form EUT Ports Tested		Dhaca		Volta	age		Criterion	Result	Judgment
LOTE	TOTIS TESTEU	Polarity	riiase	0.5kV	1kV	2kV	kV			
		+/-	0°	Α	Α	Α	-			
	L – PE	+/-	90°	Α	Α	Α	-	В	А	PASS
	(12 ohm)	+/-	180°	Α	Α	Α	-	Ь		
AC		+/-	270°	Α	Α	Α	-			
AC		+/-	0°	Α	Α	Α	-		А	PASS
	N – PE (12 ohm)	+/-	90°	Α	Α	Α	-	Б		
		+/-	180°	Α	Α	Α	-	В		
		+/-	270°	Α	Α	Α	-			

# Note:

- 1) Polarity and Numbers of Impulses: 5 Pst / Ngt at each tested mode
- 2) N/A denotes test is not applicable in this Test Report
- 3) Criterion A: No observation of any performance degradation.
- 4) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 5) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

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# 5.7 IMMUNITY TO CONDUCTED DISTURBANCES, INDUCED BY RADIO-FREQUENCY FIELDS TEST (CS)

#### **5.7.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-6
Required Performance	A
Frequency Range	0.15 MHz - 80 MHz
Field Strength	3 V (unmodulated, r.m.s.)
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1% of fundamental
Dwell Time	at least 3 seconds

#### **5.7.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Power CDN	FCC	FCC-801-M 2/M3-16A	100270	Mar. 26, 2018
2	Power Amplifier	Teseq	CBA230M- 080	T43748	Mar. 26, 2018
3	Signal Generator	HP	8648A	3636A02964	Mar. 26, 2018
4	Measurement Software	Farad	EZ-CS(V2. 0.1.2)	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

# **5.7.3 TEST PROCEDURE**

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The field strength level was 3 V (unmodulated, r.m.s.)
- b. The frequency range is swept from 150 kHz to 80 MHz, with the signal 80%amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

#### 5.7.4 DEVIATION FROM TEST STANDARD

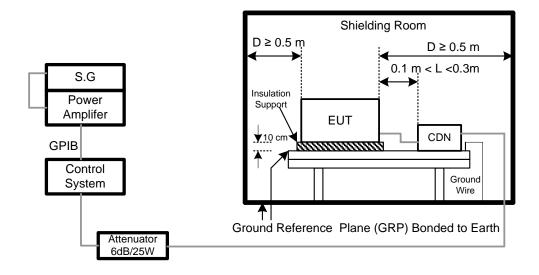
No deviation

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# 5.7.5 TEST SETUP



# NOTE:

#### FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

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# **5.7.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

Test Ports (Mode)	Freq.Range (MHz)	Field Strength	Criteria	Results	Judgment
Input/ Output AC.PowerPort	0.1580		Α	Α	PASS
Input/ Output DC. PowerPort	0.15 80	3V(unmodulat ed, r.m.s) AM Modulated 1000Hz, 80%	А	N/A	N/A
Signal Line (N/A)	0.15 80	10001.12, 0070	А	N/A	N/A

# Note:

- 1). N/A denotes test is not applicable in this test report.
- 2) Criterion A: No observation of any performance degradation.
- 3) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 4) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

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# 5.8 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST (PFMF)

#### **5.8.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-8
Required Performance	A
Frequency Range	50/60 Hz
Field Strength	1 A/m
Observation Time	1 minute
Inductance Coil	Rectangular type, 1mx1m

#### **5.8.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Magnetic Field test Generator	FCC	F-1000-4-8- G-125A	04032	Mar. 26, 2018
2	Magnetic Field immunity loop	Thermo KeyTek	F-1000-4-8/ 9/10-L-1M	04024	Mar. 26, 2018

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.8.3 TEST PROCEDURE**

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- b. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

# **5.8.4 DEVIATION FROM TEST STANDARD**

No deviation

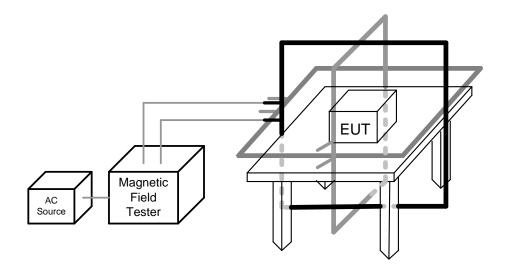
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#### 5.8.5 TEST SETUP



#### Note:

#### TABLE-TOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 percent of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

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# **5.8.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

# 50Hz

Test Mode	Test Level	Antenna aspect	Duration (s)	Criteria	Results	Judgment
Enclosure	1 A/m	Х	60	А	А	PASS
Enclosure	1 A/m	Y	60	А	А	PASS
Enclosure	1 A/m	Z	60	А	Α	PASS

# 60Hz

Test Mode	Test Level	Antenna aspect	Duration (s)	Criteria	Results	Judgment
Enclosure	1 A/m	Х	60	Α	А	PASS
Enclosure	1 A/m	Y	60	А	Α	PASS
Enclosure	1 A/m	Z	60	А	Α	PASS

# Note:

- 1). N/A denotes test is not applicable in this test report.
- 2) Criterion A: No observation of any performance degradation.
- 3) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 4) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

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# 5.9 VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS IMMUNITY TEST

# **5.9.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-11
Required Performance	B (For >95% Voltage Dips)
	C (For 30% Voltage Dips)
	C (For >95% Voltage Interruptions)
Test Duration Time	Minimum three test events in sequence
Interval between Event	Minimum ten seconds
Phase Angle	0°/180°
Test Cycle	3 times

#### **5.9.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 20, 2018
2	Measurement Software	Teseq	Win 3000 Version 1.2.0	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.9.3 TEST PROCEDURE**

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

# **5.9.4 DEVIATION FROM TEST STANDARD**

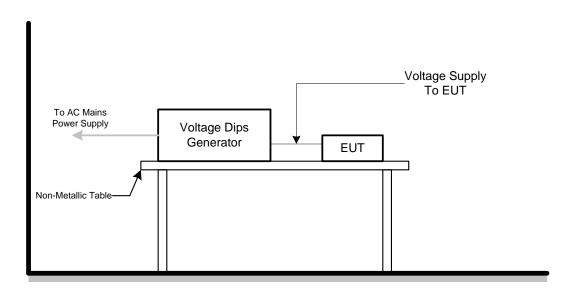
No deviation

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# 5.9.5 TEST SETUP



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# 5.9.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0250
Temperature	25°C	Relative Humidity	56%
Test Voltage	AC 230V/50Hz		
Test Mode	Operating		

AC 100V/50Hz				
Voltage Reduction	Periods	Criteria	Results	Judgment
Voltage dip >95%	0.5	В	А	PASS
Voltage dip 30%	25	С	А	PASS
Interruption>95%	250	С	С	PASS

AC 230V/50Hz				
Voltage Reduction	Periods	Criteria	Results	Judgment
Voltage dip >95%	0.5	В	А	PASS
Voltage dip 30%	25	С	А	PASS
Interruption>95%	250	С	С	PASS

AC 240V/50Hz				
Voltage Reduction	Periods	Criteria	Results	Judgment
Voltage dip >95%	0.5	В	Α	PASS
Voltage dip 30%	25	С	Α	PASS
Interruption>95%	250	С	С	PASS

# Note:

- 1). N/A denotes test is not applicable in this test report.
- 2) Criterion A: No observation of any performance degradation.
- 3) Criterion B: Some degradation of performance is observed but the equipment continues to operate as intended.
- 4) Criterion C: Loss of functionality, but self-recoverable by user, without loss of information or settings.

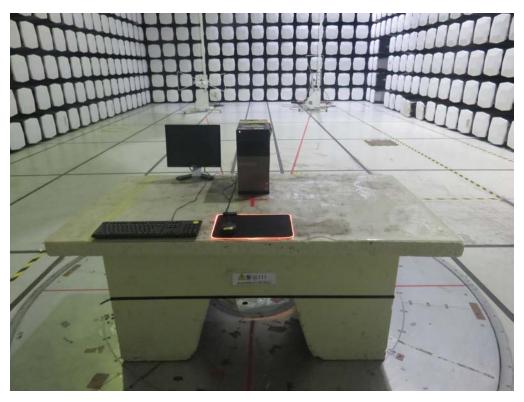
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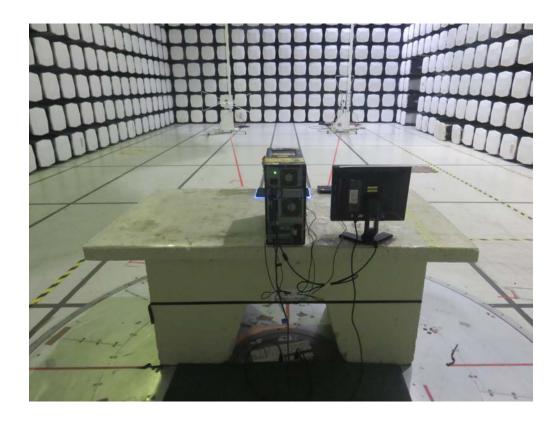




# 6. EUT TEST PHOTO







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# Conducted emissions AC mains power port





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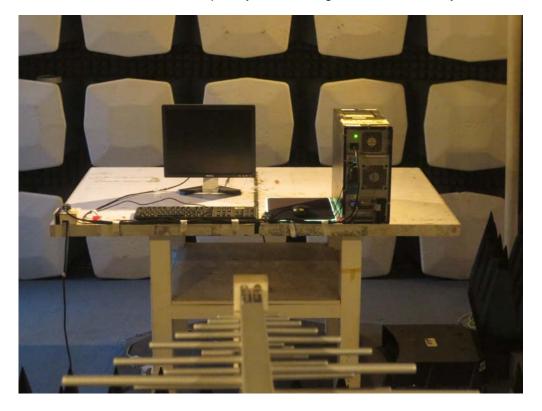




# Electrostatic discharge immunity



Radiated, radio-frequency, electromagnetic field immunity



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# Electrical fast transient/burst immunity



Surge immunity

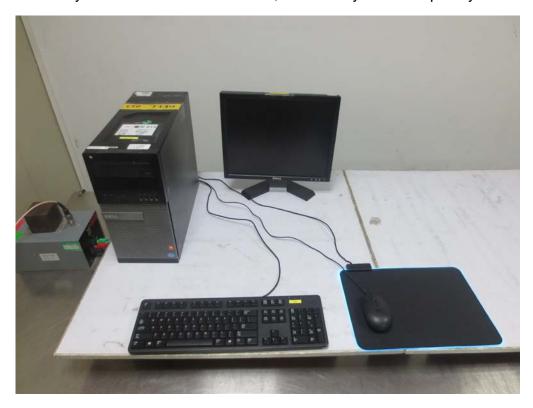


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# Immunity to conducted disturbances, induced by radio-frequency fields



Power frequency magnetic field immunity

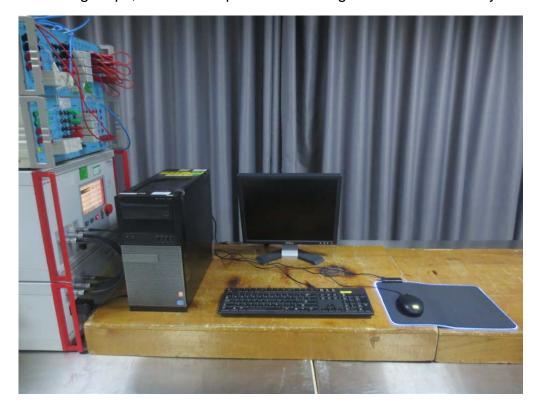


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Voltage dips, short interruptions and voltage variations immunity



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